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Contact us

Tel: +86-755-8981 8866 Fax: +86-755-8427 6832

Email & Skype: info@chipsmall.com Web: www.chipsmall.com

Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China











1000V, 42A, 0.20Ω Max, t_{rr} ≤400ns

N-Channel FREDFET

Power MOS 8^{TM} is a high speed, high voltage N-channel switch-mode power MOSFET. This 'FREDFET' version has a drain-source (body) diode that has been optimized for high reliability in ZVS phase shifted bridge and other circuits through reduced t_{rr} , soft recovery, and high recovery dv/dt capability. Low gate charge, high gain, and a greatly reduced ratio of $C_{\text{rss}}/C_{\text{iss}}$ result in excellent noise immunity and low switching loss. The intrinsic gate resistance and capacitance of the poly-silicon gate structure help control di/dt during switching, resulting in low EMI and reliable paralleling, even when switching at very high frequency.



APT41F100J
Single die FREDFET



FEATURES

- · Fast switching with low EMI
- · Low trr for high reliability
- Ultra low C_{rss} for improved noise immunity
- · Low gate charge
- · Avalanche energy rated
- RoHS compliant

TYPICAL APPLICATIONS

- · ZVS phase shifted and other full bridge
- · Half bridge
- · PFC and other boost converter
- Buck converter
- · Single and two switch forward
- Flyback

Absolute Maximum Ratings

Symbol	Parameter	Ratings	Unit
l _a	Continuous Drain Current @ T _C = 25°C	42	
'D	Continuous Drain Current @ T _C = 100°C	27	Α
I _{DM}	Pulsed Drain Current ^①	260	
V _{GS}	Gate-Source Voltage	±30	V
E _{AS}	Single Pulse Avalanche Energy ©	4075	mJ
I _{AR}	Avalanche Current, Repetitive or Non-Repetitive	33	Α

Thermal and Mechanical Characteristics

Symbol	Characteristic	Min	Тур	Max	Unit	
P _D	Total Power Dissipation @ T _C = 25°C			960	W	
$R_{\theta JC}$	Junction to Case Thermal Resistance			0.13	°C/W	
R _{ecs}	Case to Sink Thermal Resistance, Flat, Greased Surface		0.15			
T_J , T_{STG}	Operating and Storage Junction Temperature Range	-55		150	°C	
V _{Isolation}	RMS Voltage (50-60hHz Sinusoidal Waveform from Terminals to Mounting Base for 1 Min.)	2500			V	
W _T	Package Weight		1.03		OZ	
T T	æage vveigni		29.2		g	
Torque	Terminals and Mounting Screws.			10	in∙lbf	
				1.1	N·m	

Static Characteristics

T_{.I} = 25°C unless otherwise specified

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Symbol	Parameter	Test Conditions		Min	Тур	Max	Unit
V _{BR(DSS)}	Drain-Source Breakdown Voltage	$V_{GS} = 0V, I_{D} = 250\mu A$		1000			V
$\Delta V_{BR(DSS)} / \Delta T_{J}$	Breakdown Voltage Temperature Coefficient	Reference to 25°C, I _D = 250μA			1.15		V/°C
R _{DS(on)}	Drain-Source On Resistance ^③	$V_{GS} = 10V, I_{D} = 33A$			0.18	0.20	Ω
V _{GS(th)}	Gate-Source Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 5mA$		2.5	4	5	V
$\Delta V_{GS(th)}/\Delta T_{J}$	Threshold Voltage Temperature Coefficient				-10		mV/°C
	Zero Gate Voltage Drain Current	V _{DS} = 1000V	T _J = 25°C			250	μA
DSS	Zero Gate voltage Drain Current	V _{GS} = 0V	T _J = 125°C	·	·	1000	μΑ
I _{GSS}	Gate-Source Leakage Current	V _{GS} = :	±30V		·	±100	nA

Dynamic Characteristics

T₁ = 25°C unless otherwise specified

ymanno o	Tj = 20 0 unless otherwise specified					
Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
g_{fs}	Forward Transconductance	$V_{DS} = 50V, I_{D} = 33A$		75		S
C _{iss}	Input Capacitance	V 0V V 05V		18500		
C _{rss}	Reverse Transfer Capacitance	$V_{GS} = 0V, V_{DS} = 25V$ f = 1MHz		245		
C _{oss}	Output Capacitance	1 111112		1555		
$C_{o(cr)}$ $\textcircled{4}$	Effective Output Capacitance, Charge Related	V = 0V V = 0V to 667V		635		pF
C _{o(er)} ⑤	Effective Output Capacitance, Energy Related	V _{GS} = 0V, V _{DS} = 0V to 667V		325		
Q _g	Total Gate Charge	\\ -0 to 40\\ 1 - 22A		570		
Q_{gs}	Gate-Source Charge	$V_{GS} = 0 \text{ to } 10V, I_{D} = 33A,$ $V_{DS} = 500V$		100		nC
Q_{gd}	Gate-Drain Charge	V _{DS} = 500V		270		
t _{d(on)}	Turn-On Delay Time	Resistive Switching		55		
t _r	Current Rise Time	V _{DD} = 667V, I _D = 33A		55		ns
t _{d(off)}	Turn-Off Delay Time	$R_{G} = 2.2\Omega^{\textcircled{6}}, V_{GG} = 15V$		235		115
t _f	Current Fall Time			55		

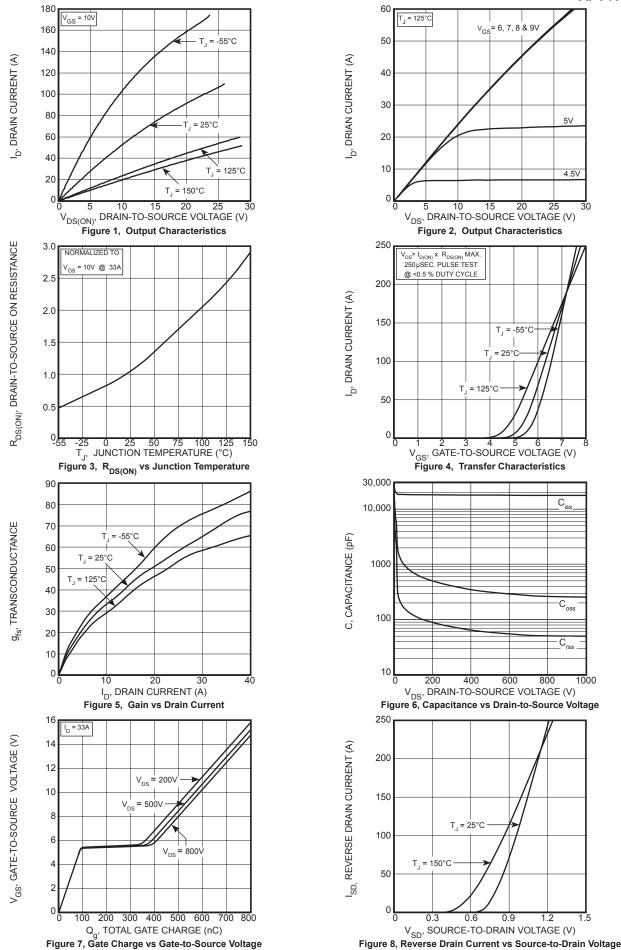
Source-Drain Diode Characteristics

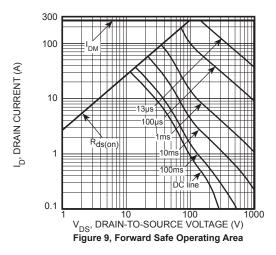
Symbol	Parameter	Test Conditions	s Min	Тур	Max	Unit
I _s	Continuous Source Current (Body Diode)	MOSFET symbol showing the	OD D		42	Α
I _{SM}	Pulsed Source Current (Body Diode) ^①	integral reverse p-n junction diode (body diode)	SUPPLY S		260	
V _{SD}	Diode Forward Voltage	$I_{SD} = 33A, T_{J} = 25^{\circ}C, V_{GS} = 0V$			1.2	V
t _{rr}	Doverse Decevery Time	T _J = 2	25°C		400	no
rr	Reverse Recovery Time	T _J = -	125°C		800	ns
0	Daviana Daasiani Chama	$I_{SD} = 33A^{3}$ $T_{J} = 2$	25°C	3.3		
Q_{rr}	Reverse Recovery Charge	$V_{DD} = 100V$ $T_{J} = 100V$	125°C	8.0		μC
ı	December 1	$di_{SD}/dt = 100A/\mu s$ $T_J = 2$	25°C	17.2		_
rrm	Reverse Recovery Current	T _J = 1	125°C	24.6		A
dv/dt	Peak Recovery dv/dt	$I_{SD} \le 33A$, di/dt $\le 1000A/\mu s$, V_{DD} $T_{J} = 125^{\circ}C$	= 667V,		25	V/ns

- ① Repetitive Rating: Pulse width and case temperature limited by maximum junction temperature.
- ② Starting at $T_J = 25$ °C, L = 7.48mH, $R_G = 25\Omega$, $I_{AS} = 33A$.
- (3) Pulse test: Pulse Width < 380µs, duty cycle < 2%.

- \bigcirc R_G is external gate resistance, not including internal gate resistance or gate driver impedance. (MIC4452)

Microsemi reserves the right to change, without notice, the specifications and information contained herein.





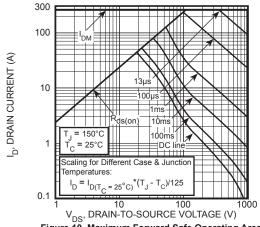
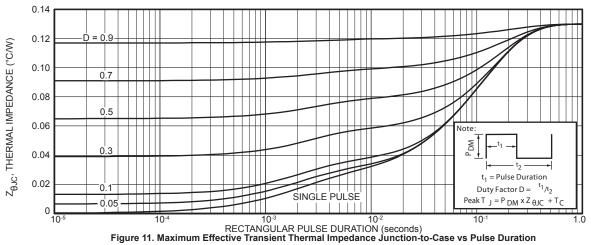
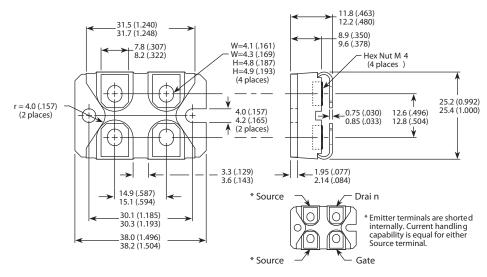


Figure 10, Maximum Forward Safe Operating Area



SOT-227 (ISOTOP®) Package Outline



Dimensions in Millimeters and (Inches)